

Notic of R ferenc s Cited

Application/Control No.

10/042,878

Applicant(s)/Patent Under
Reexamination
NEISSER ET AL.

Examiner

Nicole M. Barreca

Art Unit

1756

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6087250	07-2000	Hyakutake	438/598
	B	US-6323310	11-2001	Puligadda et al.	528/423
	C	US-6312870	11-2001	Malik et al.	430/270.1
	D	US-6537727	03-2003	Yoon et al.	430/270.1
	E	US-6365322	04-2002	Panmanaban et al.	430/270.1
	F	US-6447980	09-2002	Rahman et al.	430/270.1
	G	US-5688365	11-1997	Ogishi	156/661.11
	H	US-6399481	06-2002	Yamada	438/636
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 942331	09-1999	EP	Padmanaban et al.	G03F 7/11
	O	JP 9-260255	10-1997	JP	Toshiyuki et al.	H01L 21/027
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.